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| Atty. Docket No.                     | <u>Serial No.</u> |
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| SEL 161                              | 09/500,897        |
| <u>Applicant</u><br>Shunpei YAMAZAKI | ·                 |
| <u>Filing Date</u>                   | <u>Group</u>      |
| February 9, 2000                     | 2612              |

## U.S. PATENT DOCUMENTS

| *EXAMINER<br>INITIAL | DOCUMENT<br>NUMBER | DATE | NAME | CLASS | SUB-<br>CLASS | FILING<br>DATE |
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## FOREIGN PATENT DOCUMENTS

| TOWARD DOCUMENT |                    |          |               |                     |                   |                |  |
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|                 | DOCUMENT<br>NUMBER | DATE     | APPLICANT     | English<br>Abstract | English<br>Trans. | FILING<br>DATE |  |
|                 | JP 04-125683       | 04/27/92 | Toshiba Corp. |                     | х                 | 09/18/90       |  |

## OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS

(Include name of author (in CAPITAL LETTERS), title of article or item (book, magazine, journal, serial, symposium, catalog, etc.) date, pages(s), volume-issue number(s), publisher, city and/or country where published).

EXAMINER:

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